



SANYO Semiconductors

DATA SHEET

N-Channel Silicon MOSFET

CPH5612 — General-Purpose Switching Device Applications

Features

- Low ON-resistance.
- Ultrahigh-speed switching.
- 2.5V drive.
- Composite type with 2 MOSFETs contained in a single package, facilitating-density mounting.

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	V _{DSS}		100	V
Gate-to-Source Voltage	V _{GSS}		±10	V
Drain Current (DC)	I _D		1	A
Drain Current (Pulse)	I _{DP}	PW≤10μs, duty cycle≤1%	4	A
Allowable Power Dissipation	P _D	Mounted on a ceramic board (600mm²×0.8mm) 1unit	0.9	W
Channel Temperature	T _{ch}		150	°C
Storage Temperature	T _{stg}		-55 to +150	°C

Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	I _D =1mA, V _{GS} =0	100			V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} =100V, V _{GS} =0			1	μA
Gate-to-Source Leakage Current	I _{GSS}	V _{GS} =±8V, V _{DS} =0			±10	μA
Cutoff Voltage	V _{GS(off)}	V _{DS} =10V, I _D =1mA	0.4		1.3	V
Forward Transfer Admittance	y _{fs}	V _{DS} =10V, I _D =500mA	1.8	2.6		S
Static Drain-to-Source On-State Resistance	R _{DS(on)1}	I _D =500mA, V _{GS} =4V		430	570	mΩ
	R _{DS(on)2}	I _D =500mA, V _{GS} =2.5V		450	650	mΩ
Input Capacitance	C _{iss}	V _{DS} =20V, f=1MHz		350		pF
Output Capacitance	C _{oss}	V _{DS} =20V, f=1MHz		20		pF
Reverse Transfer Capacitance	C _{rss}	V _{DS} =20V, f=1MHz		12		pF
Turn-ON Delay Time	t _{d(on)}	See specified Test Circuit.		15		ns
Rise Time	t _r	See specified Test Circuit.		11		ns
Turn-OFF Delay Time	t _{d(off)}	See specified Test Circuit.		54		ns
Fall Time	t _f	See specified Test Circuit.		30		ns

Marking : FS

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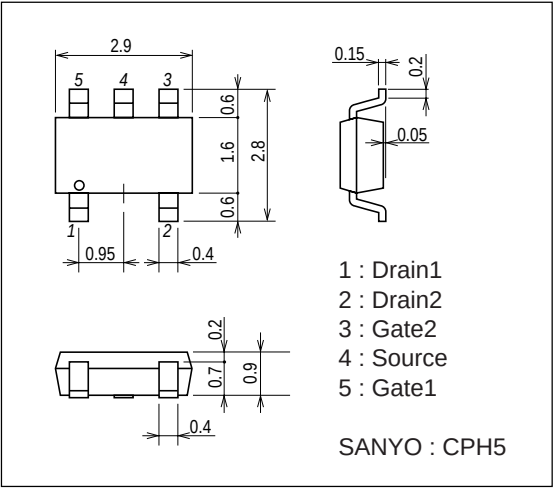
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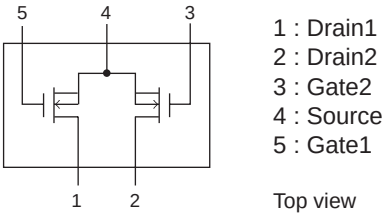
Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Total Gate Charge	Qg	V _{DS} =50V, V _{GS} =4V, I _D =1A		4.4		nC
Gate-to-Source Charge	Qgs	V _{DS} =50V, V _{GS} =4V, I _D =1A		1.2		nC
Gate-to-Drain "Miller" Charge	Qgd	V _{DS} =50V, V _{GS} =4V, I _D =1A		0.8		nC
Diode Forward Voltage	V _{SD}	I _S =1A, V _{GS} =0		0.82	1.2	V

Package Dimensions

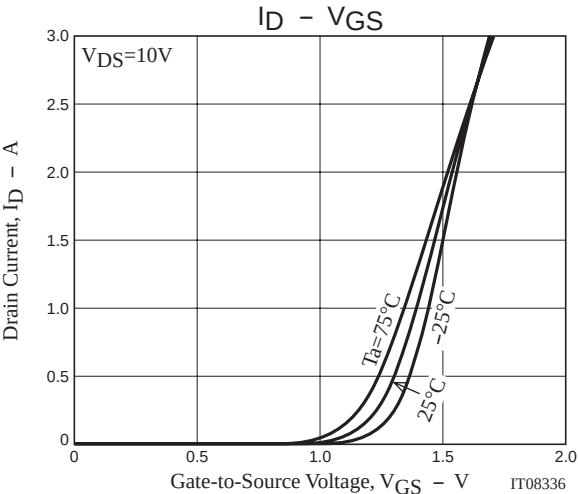
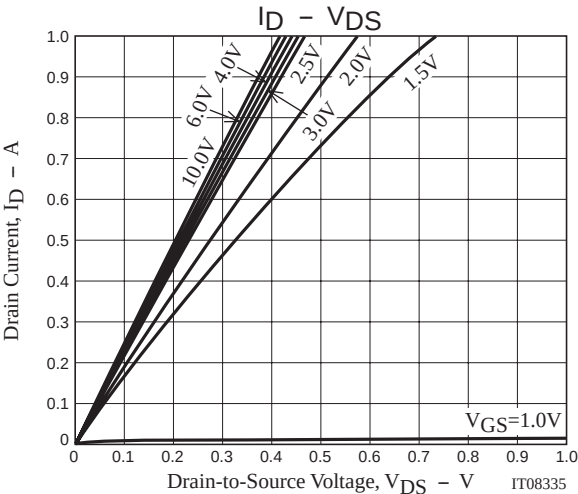
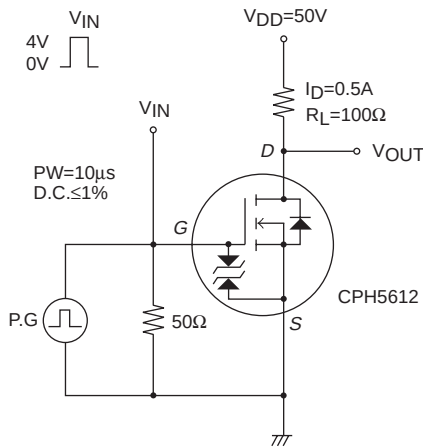
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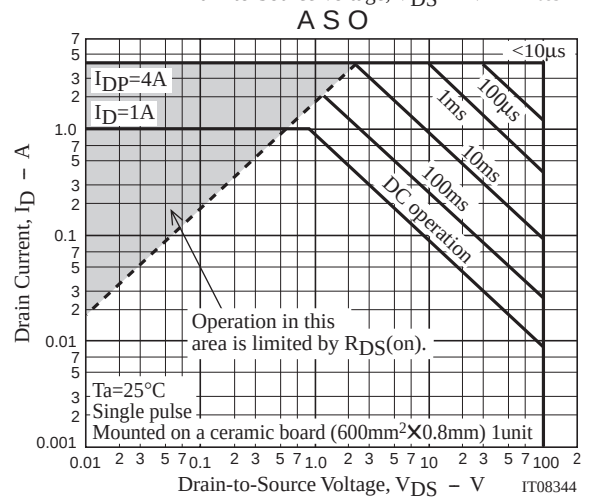
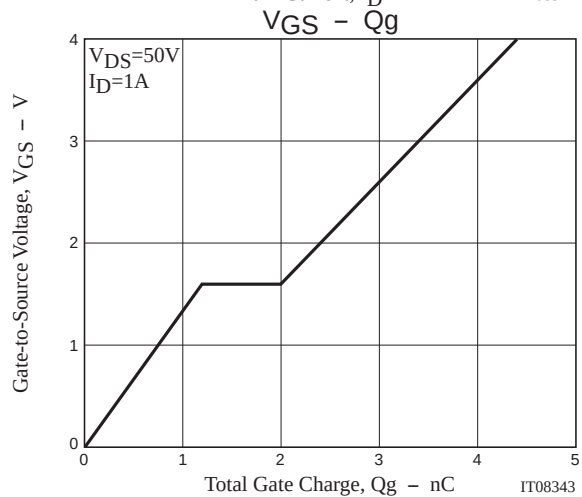
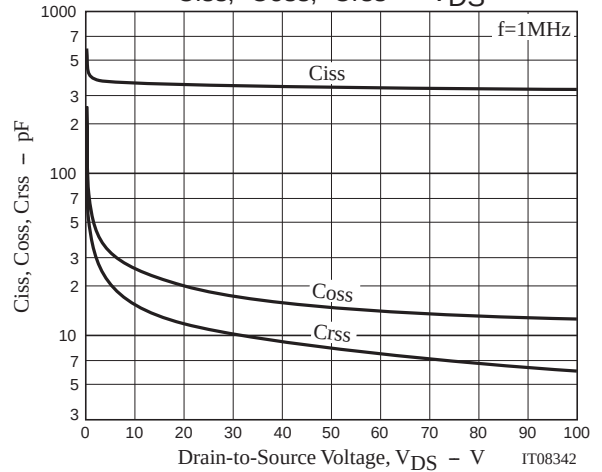
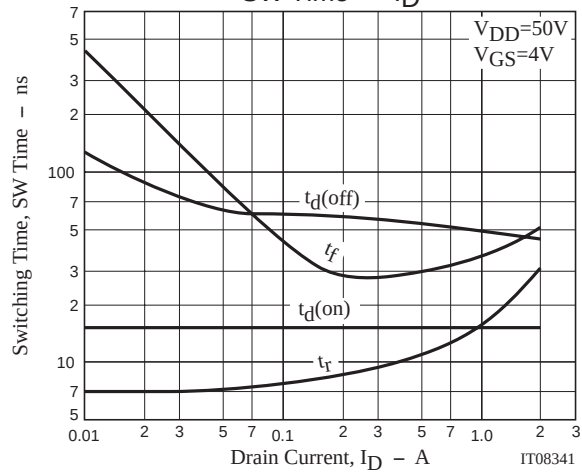
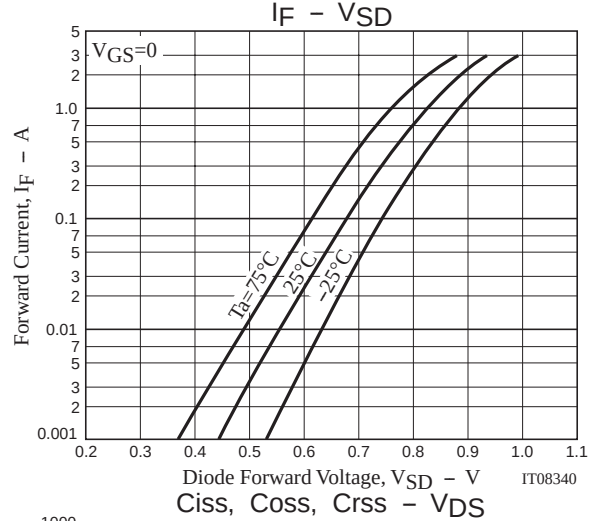
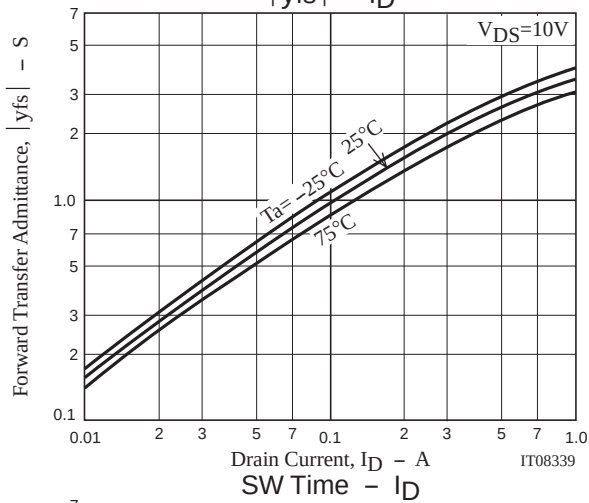
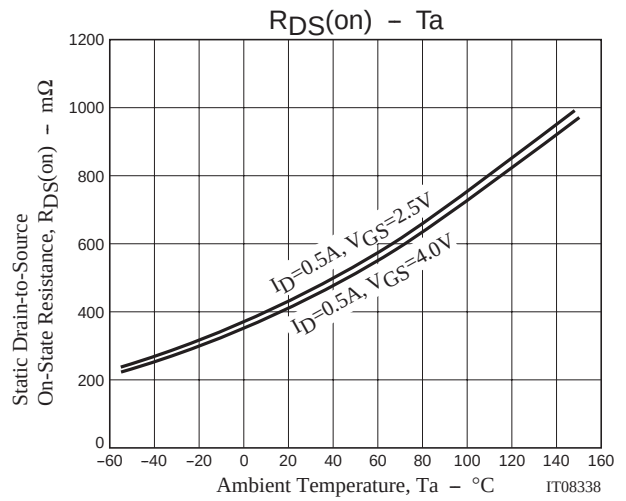
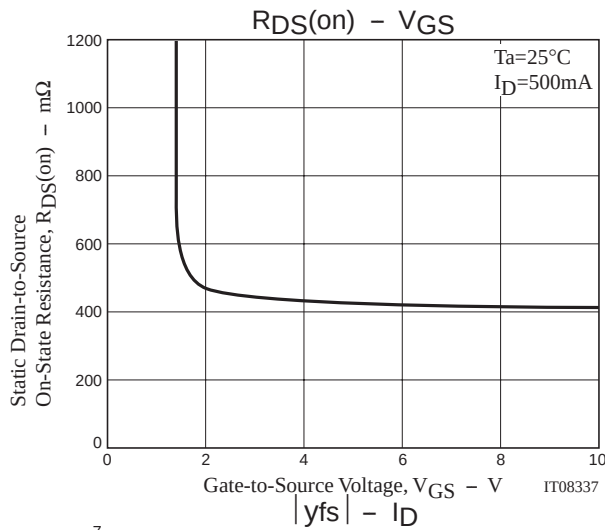


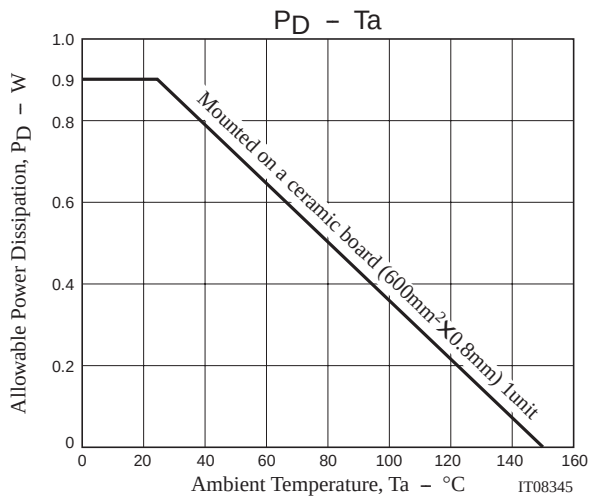
Electrical Connection



Switching Time Test Circuit







Note on usage : Since the CPH5612 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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